

DAC025N065L1

650V

Silicon Carbide Enhancement Mode MOSFET

Features

- High blocking voltage with low Rds(on)
- High frequency operation with low Capacitance
- Simple to drive with -4V/+15V gate
- Robust body diode with low Qrr
- 100% Avalanche tested

Benefits

- · Superior robustness and system reliability
- Higher system efficiency
- · Easier paralleling without thermal runaway
- Capable of high temperature application
- · Faster and more efficient switching

Applications

- Server power
- EV/HEV charging station
- · Energy storage systems
- High performance DC-DC converters
- · On-board charger
- · Battery management systems



 V_{DSS}



Absolute Maximum Ratings

(Tc = 25°C unless otherwise specified)

| Parameter | | | Ratings | Unit |
|--------------------------------------|---|-----------------|------------------------|------|
| Drain-Source Voltage | V _{GS} =0V I₀=100µA | V _{DS} | 650 | V |
| Gate-Source Voltage (dynamic) | AC (f>1 Hz, duty cycle<1%, pulse width<200ns) | V _{GS} | V _{GS} -8/+19 | |
| Gate-Source Voltage (static) | | | -4/+15 | V |
| Drain Current-Continuous | @ T _c =25°C @ T _c =100°C | ١ _D | 85 60 | А |
| Pulse Drain Current | | | 170 | А |
| Power Dissipation | | | 326 | W |
| Storage Temperature Range | | | -55 to +175 | °C |
| Operating Junction Temperature Range | | | -55 to +175 | °C |
| Thermal Resistance, Junction-to | TL | 260 | °C | |
| Avalanche Capability, single pul | V _{DD} =100V se * V _{GS} =10V L=2mH | I _{AV} | 36 | A |
| Avalanche Capability, single puls | V _{DD} =100V V _{GS} =10V L=2mH | E _{AV} | 1200 | mJ |

* 100% tested in 60% rating

** 100% tested in 36% rating

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| SYMBOL | DIMENSIONS | | | | |
|--------|------------|-------|-------|--|--|
| | MIN. | NOM. | MAX. | | |
| А | 2.20 | 2.30 | 2.40 | | |
| A1 | 1.70 | 1.80 | 1.90 | | |
| b | 0.70 | 0,80 | 0,90 | | |
| b1 | 9.70 | 9,80 | 9,90 | | |
| b3 | 1.10 | 1.20 | 1.30 | | |
| с | 0,40 | 0,50 | 0,60 | | |
| D | 10.28 | 10.38 | 10.48 | | |
| D1 | 10.98 | 11.08 | 11.18 | | |
| D2 | 3.20 | 3.30 | 3.40 | | |
| D4 | 4.45 | 4,55 | 4.65 | | |
| Е | 9.80 | 9,90 | 10.00 | | |
| E1 | 8.00 | 8.10 | 8.20 | | |
| E2 | 0.60 | 0_70 | 0.80 | | |
| е | 1.20 BSC | | | | |
| н | 11.58 | 11.68 | 11.78 | | |
| H1 | 6.95 BSC | | | | |
| H2 | 5.89 BSC | | | | |
| I | 0.10 REF. | | | | |
| j | 0.46 REF. | | | | |
| К | 2.80 REF. | | | | |
| L | 1.40 | 1.90 | 2.10 | | |
| L1 | 0.60 | 0.70 | 0.80 | | |
| L2 | 0.50 | 0.60 | 0,70 | | |
| L3 | 0.30 | 0.70 | 0.80 | | |
| N | 8 | | | | |
| Q | 6,80 REF, | | | | |
| R | 3.00 | 3.10 | 3.20 | | |
| 0 | 10° REF. | | | | |

NOTE

NOTE: 1. REFER TO JEDEC MO-299B. 2. All DIMENSIONS ARE IN MM, ANGLES IN DEGREES. 3. DIMENSIONS DO NOT INCLUSIVE BURRS AND MOLD FLASH. 4. "*" IS FOR REFERENCE.



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| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit | | | |
|--------------------------------------|----------------------|---|------|------|------|------|--|--|--|
| OFF Characteristics | | | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V • I _D =0.1mA | 650 | - | - | V | | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} =0V • V _{DS} =650V | - | 0.5 | 60 | μA | | | |
| Gate-Source Leakage Current | I _{GSS} | V _{GS} =15V, V _{DS} =0V | - | 5 | 100 | nA | | | |
| ON Characteristics | | | | | | | | | |
| Gate Threshold Voltage ** | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_D = 10 \text{mA}$ | 2.0 | 2.8 | 3.5 | V | | | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} =15V , I _D =30A | - | 25 | 32 | mΩ | | | |
| Transconductance | g _{fs} | V _{DS} =20V , I _D =30A | - | 27 | - | S | | | |
| Internal Gate Resistance | R _{G(int.)} | | - | 1.5 | - | Ω | | | |
| Dynamic Characteristics | | | | | | | | | |
| Input Capacitance | C _{iss} | Vpc=400V | - | 2500 | - | pF | | | |
| Output Capacitance | C _{oss} | V _{GS} =0V | - | 185 | - | | | | |
| Reverse Transfer Capacitance | C _{rss} | Freq.=1MHz | - | 8 | - | | | | |
| Coss Stored Energy | E _{oss} | $V_{AC} = 25 \text{mV}$ | - | 19 | - | μJ | | | |
| Turn-On Switching Energy | E _{on} | V_{DS} =400V , V_{GS} =-4/+15V I _D =30A , $R_{G(ext)}$ =2.0Ω L=200µA | - | 36 | - | μJ | | | |
| Turn-Off Switching Energy | E _{off} | | - | 28 | - | | | | |
| Switching Characteristics | | | | | | | | | |
| Turn-On Delay Time | t _{d(on)} | $V_{DS} = 400V$ $V_{GS} = -4/+15V$ $I_{D} = 30A$ $R_{G(ext)} = 2.0\Omega$ $L = 200 \mu A$ | - | 15 | - | ns | | | |
| Rise Time | tr | | - | 18 | - | | | | |
| Turn-Off Delay Time | t _{d(off)} | | - | 29 | - | | | | |
| Fall Time | t _f | | - | 6 | - | | | | |
| Total Gate Charge | Qg | V _{PC} =400V | - | 108 | - | | | | |
| Gate to Source Charge | Q _{gs} | V _{GS} =-4/+15V | - | 28 | - | nC | | | |
| Gate to Drain Charge | Q _{gd} | I _D =30A | - | 40 | - | | | | |
| Body Diode Characteristics | | | | | | | | | |
| Inverse Diode Forward Voltage | V _{SD} | V _{GS} =-4V , I _{SD} =20A | - | 4.3 | - | V | | | |
| Continuous Diode Forward Current | I _S | V _{GS} =-4V , T _J =25°C | - | - | 56 | А | | | |
| Reverse Recovery Time | T _{rr} | I _{SD} =30A → V _{GS} =-4V V _R =400V → T _J =25°C dif/dt=1420A/µs | - | 22 | - | ns | | | |
| Reverse Recovery Charge | Q _{rr} | | - | 240 | - | nC | | | |
| Reverse Recovery Charge | Irrm | | - | 23 | - | А | | | |
| Thermal Resistance | | | | | | | | | |
| Thermal Resistance, Junction-to-Case | Rθ _{JC} | | - | 0.46 | 0.55 | °C/W | | | |

Electrical Characteristics @ Tc =25°C (unless otherwise specified)

** Turn-off with -4V gate bias is highly recommended











Fig 8. Body Diode Characteristics @ -40°C

-4

0

10 20 30 50

Gate Charge, Q_G (nC)

60

40

70 80 100 110

90



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Typical Performance



Fig 15. 3rd Quadrant Characteristics @ 175°C







Fig 14. 3rd Quadrant Characteristics @ 25°C



Fig 16. Output Capacitor Stored Energy











20

30

50

0

Rev1.0

0

10

EON

Eo

50

60

40

Drain to Source Current, IDS (A)

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70

200

100

0

0

5

20

E

Ede

15

10

External Gate Resistor, R_G (ext) (Ω)







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